

CORRECTION | AUGUST 24 2011

## Publisher's Note: "The FAST module: An add-on unit for driving commercial scanning probe microscopes at video rate and beyond" [Rev. Sci. Instrum. 82, 053702 (2011)] ✓


Friedrich Esch; Carlo Dri; Alessio Spessot; Cristina Africh; Giuseppe Cautero; Dario Giuressi; Rudi Sergo; Riccardo Tommasini; Giovanni Comelli




Rev. Sci. Instrum. 82, 089902 (2011)

<https://doi.org/10.1063/1.3630945>







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
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(Received 13 May 2011; published online 24 August 2011)

[doi:[10.1063/1.3630945](https://doi.org/10.1063/1.3630945)]

This article was originally published online on 11 May 2011 with the acronym ISA incorrectly defined. AIP apologizes for this error.

The acronym was correct as it appeared in the printed version of the article. All online versions of the article were corrected on 19 May 2011.

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